S arch Notes

Applicati n/C ntr l No.	Applicant(s)/Patent under Reexamination	•
10/774,267	JOHNSON ET AL.	
Examiner	Art Unit	
Dieu-Minh Le	2114	

	SEARCHED					
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INTERFERENCE SEARCHED					
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
EAST search files USPAT, USPGPUB, USOCR, EPO, JPO, DERWENT, IBM-TDB.	7/19/2006	DML			
Inventor name search.	7/19/2006	DML			
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